


PRODUCT / PROCESS CHANGE NOTIFICATION

1. PCN basic data

| | | |
|----------------------|-----------------------------------------------------------------------------------|--------------------------------------|
| 1.1 Company |  | STMicroelectronics International N.V |
| 1.2 PCN No. | ADG/23/14177 | |
| 1.3 Title of PCN | L9959x (UM29,MV19): Diffusion Transfer to SMEC Foundry | |
| 1.4 Product Category | see list | |
| 1.5 Issue date | 2023-06-13 | |

2. PCN Team

| | |
|----------------------------------|--------------------------|
| 2.1 Contact supplier | |
| 2.1.1 Name | ROBERTSON HEATHER |
| 2.1.2 Phone | +1 8475853058 |
| 2.1.3 Email | heather.robertson@st.com |
| 2.2 Change responsibility | |
| 2.2.1 Product Manager | Fabrizio CASSANI |
| 2.1.2 Marketing Manager | Alberto CAROLI |
| 2.1.3 Quality Manager | Alberto BIGNAZZI |

3. Change

| | | |
|---------------------|------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------|
| 3.1 Category | 3.2 Type of change | 3.3 Manufacturing Location |
| Transfer | Line transfer for a full process or process brick (process step, control plan, recipes) from one site to another site: Wafer fabrication | SMEC Foundry - Shaoxing (China). |

4. Description of change

| | | |
|---------------------------------------------------------------------------------------|-----------------------------------------------|------------------------------------------------------------------------------------------|
| | Old | New |
| 4.1 Description | Diffusion Locations: ST Agrate / ST Singapore | Diffusion Location: SMEC 2nd source approach possibility for ST Agrate / ST Singapore |
| 4.2 Anticipated Impact on form,fit, function, quality, reliability or processability? | No Impact | |

5. Reason / motivation for change

| | |
|----------------------|--------------------------------------------------------------------------------------------------------------|
| 5.1 Motivation | Service and Capacity improvement. Diffusion transfer is going to allow increased overall Front-End capacity. |
| 5.2 Customer Benefit | SERVICE IMPROVEMENT |

6. Marking of parts / traceability of change

| | |
|-----------------|-------------------------------|
| 6.1 Description | Dedicated Finished Good codes |
|-----------------|-------------------------------|

7. Timing / schedule

| | |
|-------------------------------------|--------------|
| 7.1 Date of qualification results | 2023-12-15 |
| 7.2 Intended start of delivery | 2024-01-01 |
| 7.3 Qualification sample available? | Upon Request |

8. Qualification / Validation

| | | | |
|----------------------------------------------------|-------------|------------|--|
| 8.1 Description | | | |
| 8.2 Qualification report and qualification results | In progress | Issue Date | |

9. Attachments (additional documentations)

14177 Public product.pdf
14177 Details.pdf

| 10. Affected parts | | |
|-------------------------|-------------------------|--------------------------|
| 10. 1 Current | | 10.2 New (if applicable) |
| 10.1.1 Customer Part No | 10.1.2 Supplier Part No | 10.1.2 Supplier Part No |
| | L9959S-TR-D | |
| | L9959T-TR-D | |

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PRODUCT/PROCESS CHANGE NOTIFICATION

| | |
|---------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| TITLE | L9959x (UM29, MV19): Diffusion Transfer to SMEC Foundry |
| IMPACTED PRODUCTS | <p>Following ST lines manufactured in BCD6s technology:</p> <ul style="list-style-type: none"> ✚ UM29 diffused in Agrate/Singapore and assembled in PowerSSO24 package (Muar) ✚ UM29 diffused in Agrate/Singapore and assembled in PowerSSO36 package (Muar) ✚ MV19 diffused in Agrate/Singapore and assembled in PowerSSO36 package (Muar) <p>Detailed part numbers list is attached.</p> |
| MANUFACTURING STEP | Wafers diffusion. |
| INVOLVED PLANT | SMEC Foundry (ST Subcontractor) located in Shaoxing (China). |
| CHANGE REASON | Service and Capacity improvement. Diffusion transfer is going to allow increased overall Front-End capacity. |
| CHANGE DESCRIPTION | Product diffusion transfer from ST Agrate and ST Singapore to SMEC Foundry. A brief Company introduction with relevant Automotive Certifications (e.g. IATF16949) is attached. |
| TRACEABILITY | Dedicated Finished Good codes. |
| VALIDATION | Validation according to AEC-Q100 and AEC-Q006 standards, by applying ZVEI Delta Qualification Matrix item SEM-PW-13 - Move all or parts of production to a different wafer fab site, resulting in the plan shown here below: |

| | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
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| | <table><tr><td>•</td><td>A2</td><td>THB</td><td>Temperature Humidity Bias or biased HAST</td></tr><tr><td>•</td><td>A3</td><td>AC</td><td>Autoclave or Unbiased HAST</td></tr><tr><td>•</td><td>A4</td><td>TC</td><td>Temperature Cycling</td></tr><tr><td>M</td><td>A5</td><td>PTC</td><td>Power Temperature Cycling</td></tr><tr><td>•</td><td>A6</td><td>HTSL</td><td>High Temperature Storage Life</td></tr><tr><td>•</td><td>B1</td><td>HTOL</td><td>High Temperature Operating Life</td></tr><tr><td>•</td><td>B2</td><td>ELFR</td><td>Early Life Failure Rate</td></tr><tr><td>•</td><td>C1</td><td>WBS</td><td>Wire Bond Shear</td></tr><tr><td>•</td><td>C2</td><td>WBP</td><td>Wire Bond Pull</td></tr><tr><td>•</td><td>D1</td><td>EM</td><td>Electromigration</td></tr><tr><td>•</td><td>D2</td><td>TDDB</td><td>Time Depending Dielectric Breakdown</td></tr><tr><td>•</td><td>D3</td><td>HCI</td><td>Hot Carrier Injection</td></tr><tr><td>•</td><td>D4</td><td>NBTI</td><td>Negative Bias Temperature Instability</td></tr><tr><td>•</td><td>D5</td><td>SM</td><td>Stress Migration</td></tr><tr><td>•</td><td>E2</td><td>HBM</td><td>Electronic Discharge Human Body Model</td></tr><tr><td>•</td><td>E3</td><td>CDM</td><td>Electronic Discharge Charged Device Model</td></tr><tr><td>•</td><td>E4</td><td>LU</td><td>Latch up</td></tr><tr><td>•</td><td>E5</td><td>ED</td><td>Electrical Distribution</td></tr><tr><td>•</td><td colspan="3">For Cu Wire Products: Consider AEC-Q006</td></tr></table> | • | A2 | THB | Temperature Humidity Bias or biased HAST | • | A3 | AC | Autoclave or Unbiased HAST | • | A4 | TC | Temperature Cycling | M | A5 | PTC | Power Temperature Cycling | • | A6 | HTSL | High Temperature Storage Life | • | B1 | HTOL | High Temperature Operating Life | • | B2 | ELFR | Early Life Failure Rate | • | C1 | WBS | Wire Bond Shear | • | C2 | WBP | Wire Bond Pull | • | D1 | EM | Electromigration | • | D2 | TDDB | Time Depending Dielectric Breakdown | • | D3 | HCI | Hot Carrier Injection | • | D4 | NBTI | Negative Bias Temperature Instability | • | D5 | SM | Stress Migration | • | E2 | HBM | Electronic Discharge Human Body Model | • | E3 | CDM | Electronic Discharge Charged Device Model | • | E4 | LU | Latch up | • | E5 | ED | Electrical Distribution | • | For Cu Wire Products: Consider AEC-Q006 | | |
| • | A2 | THB | Temperature Humidity Bias or biased HAST | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | A3 | AC | Autoclave or Unbiased HAST | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | A4 | TC | Temperature Cycling | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| M | A5 | PTC | Power Temperature Cycling | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | A6 | HTSL | High Temperature Storage Life | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | B1 | HTOL | High Temperature Operating Life | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | B2 | ELFR | Early Life Failure Rate | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | C1 | WBS | Wire Bond Shear | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | C2 | WBP | Wire Bond Pull | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | D1 | EM | Electromigration | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | D2 | TDDB | Time Depending Dielectric Breakdown | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | D3 | HCI | Hot Carrier Injection | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | D4 | NBTI | Negative Bias Temperature Instability | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | D5 | SM | Stress Migration | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | E2 | HBM | Electronic Discharge Human Body Model | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | E3 | CDM | Electronic Discharge Charged Device Model | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | E4 | LU | Latch up | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | E5 | ED | Electrical Distribution | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| • | For Cu Wire Products: Consider AEC-Q006 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| | <p>To cover the different Front-End vs. Back-End configurations the following scheme has been adopted:</p> <ul style="list-style-type: none">✚ 1 lot UM29 - PowerSSO24✚ 2 lots MV19 - PowerSSO36 (covering UM29 - PowerSSO36 for similarity) | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| CURRENT PRODUCTS | New diffusion site SMEC will be used for production, with 2 nd source approach possibility for the sending plants. | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| REPORTS | Qualification activity is in progress, with completion forecast by end 2023. | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |



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PCN Title : L9959x (UM29,MV19): Diffusion Transfer to SMEC Foundry

PCN Reference : ADG/23/14177

Subject : Public Products List

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Please find below the Standard Public Products List impacted by the change.

| | | |
|-------------|-------------|-------------|
| L9959S-TR-D | L9959U-TR-D | L9959T-TR-D |
|-------------|-------------|-------------|

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